



SBOS127C - JULY 2000 - REVISED NOVEMBER 2003

**OPA452** 

**OPA453** 

# 80V, 50mA OPERATIONAL AMPLIFIERS

## **FEATURES**

- WIDE POWER-SUPPLY RANGE: ±10V to ±40V
- HIGH OUTPUT LOAD DRIVE: 50mA Continuous
- WIDE OUTPUT VOLTAGE SWING: 1V to Rail
- FULLY PROTECTED: Thermal Shutdown Output Current-Limited
- WIDE OPERATING TEMPERATURE RANGE: -40°C TO +125°C
- PACKAGE OPTIONS: TO220-7 DDPACK-7 Surface-Mount

## **APPLICATIONS**

- PIEZOELECTRIC CELLS
- TEST EQUIPMENT
- AUDIO AMPLIFIERS
- TRANSDUCER DRIVERS
- SERVO DRIVERS

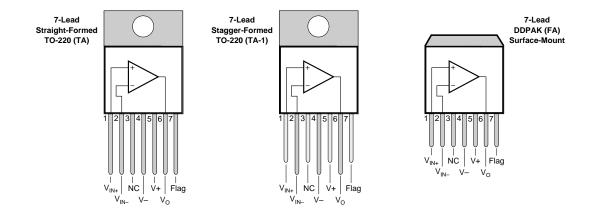
## DESCRIPTION

The OPA452 and OPA453 are low-cost operational amplifiers with high-voltage (80V) and high-current capabilities (50mA). The OPA452 is unity-gain stable and has a gain bandwidth product of 1.8MHz, whereas the OPA453 is optimized for gains greater than 5 and has a 7.5MHz bandwidth.

The OPA452 and OPA453 are internally protected against over-temperature conditions and current overloads. Power supplies in the range of  $\pm 10V$  to  $\pm 40V$  can be used. Unlike most other power op amps, the OPA452 and OPA453 have ensured specifications over the entire power-supply range.

These laser-trimmed, monolithic integrated circuits provide excellent low-level accuracy along with wide output swing. Special design considerations assure that the product is easy to use and free from phase inversion problems often found in other amplifiers.

The OPA452 and OPA453 are available in TO220-7 and DDPAK-7 options. They are specified for a junction temperature range of  $-40^{\circ}$ C to  $+125^{\circ}$ C.



NOTE: Tabs are electrically connected to V- supply.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



#### **ABSOLUTE MAXIMUM RATINGS(1)**

Supply Voltage, V+ to V Signal Input Terminals, Voltage <sup>(2)</sup> (V-) - 0.5V to (V+	) + 0.5V
Current <sup>(2)</sup>	5mA
Output Short-Circuit Con	ntinuous
Operating Temperature55°C to	+125°C
Storage Temperature65°C to	+150°C
Junction Temperature	+150°C
Lead Temperature (soldering 10s, TO-220)	300°C
(soldering 3s, DDPAK)	240°C

NOTES: (1) Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. (2) Input terminals are diode-clamped to the power-supply rails. Input signals that can swing more than 0.5V beyond the supply rails should be current limited to 5mA or less.

### PACKAGE/ORDERING INFORMATION

For the most current package and ordering information, see the Package Option Addendum located at the end of this data sheet.



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.



# ELECTRICAL CHARACTERISTICS: OPA452; V\_s = $\pm 10V$ to $\pm 40V$

**Boldface** limits apply over the specified junction temperature range,  $T_J = -40^{\circ}C$  to  $+125^{\circ}C$ .

At T<sub>J</sub> = +25°C, R<sub>L</sub> = 3.8k $\Omega$  connected to ground, and V<sub>OUT</sub> = 0V, unless otherwise noted.

				OPA452TA, FA		
PARAMETER		CONDITION	MIN	MAX	UNITS	
OFFSET VOLTAGE Input Offset Voltage over Temperature Drift vs Power Supply over Temperature	V <sub>os</sub> dV <sub>os</sub> /dT PSRR	$V_{S} = \pm 40V, V_{CM} = 0V, I_{O} = 0V$ $V_{S} = \pm 10V$ to $\pm 40V, V_{CM} = 0V$		±1 ± <b>5</b> 5	±3 ±6 30 45	mV <b>mV</b> μ <b>V/°C</b> μV/V μ <b>V/V</b>
INPUT BIAS CURRENT <sup>(1)</sup>						
Input Bias Current Input Offset Current	I <sub>B</sub> I <sub>OS</sub>			±7 ±1	±100 ±100	pA pA
NOISE Input Voltage Noise Density Current Noise Density	e <sub>n</sub> i <sub>n</sub>	f = 1kHz f = 1kHz		21 9		nV/√Hz fA/√Hz
INPUT VOLTAGE RANGE Common-Mode Voltage Range Common-Mode Rejection Ratio over Temperature	V <sub>CM</sub> CMRR	V <sub>S</sub> = ±40V, −35V < V <sub>CM</sub> < 39.5V V <sub>S</sub> = ±40V, −35V < V <sub>CM</sub> < 39.5V	(V–) + 5 86 <b>76</b>	94	(V+) - 0.5	V dB <b>dB</b>
INPUT IMPEDANCE Differential Common-Mode		V <sub>S</sub> = ±40V, -35V < V <sub>CM</sub> < 39.5V		10 <sup>13</sup>    2 10 <sup>13</sup>    6		Ω    pF Ω    pF
OPEN-LOOP GAIN Open-Loop Voltage Gain over Temperature	A <sub>OL</sub>	$I_{O} = 10mA, -V_{S} + 2V < V_{O} < +V_{S} - 2V$ $I_{O} = 10mA, -V_{S} + 2V < V_{O} < +V_{S} - 2V$ $I_{O} = 50mA, -V_{S} + 4V < V_{O} < +V_{S} - 4V$	105 96	110 <b>107</b> 110		dB dB dB
over Temperature		$I_0 = 50 \text{mA}, -V_s + 5V < V_0 < +V_s - 5.5V$		105		dB
FREQUENCY RESPONSE Gain-Bandwidth Product Slew Rate Settling Time: 0.1% 0.01% Overload Recovery Time Total Harmonic Distortion + Noise	GBW SR THD+N	$\begin{array}{c} V_{S}=\pm 40V\\ V_{S}=\pm 40V\\ V_{S}=\pm 40V, \ G=\pm 1, \ 10V \ Step, \ C_{L}=100pF\\ V_{S}=\pm 40V, \ G=\pm 1, \ 10V \ Step, \ C_{L}=100pF\\ V_{IN}\bullet\ Gain=V_{S}\\ V_{S}=\pm 40V, \ V_{O}=30Vp\text{-}p, \ G=5\\ f=1kHz, \ R_{L}=2k\Omega \end{array}$		1.8 +7.2/-10 2 5 1 0.0008		MHz V/μs μs μs %
OUTPUT Voltage Output over Temperature Voltage Output over Temperature Output Current Short-Circuit Current Capacitive Load Drive	V <sub>OUT</sub> I <sub>SC</sub> C <sub>LOAD</sub>	I <sub>O</sub> = 50mA I <sub>O</sub> = <b>50mA</b> I <sub>O</sub> = 10mA I <sub>O</sub> = <b>10mA</b>	(V−) + 4.0 (V−) + 5 (V−) + 2 (V−) + 2 ±50 See	±125 Typical Characto	$(\vee +) - 4$ $(\vee +) - 5.5$ $(\vee +) - 2$ $(\vee +) - 2$ $(\vee +) - 2$ eristic	V V V mA mA
SHUTDOWN FLAG Thermal Shutdown Status Output Normal Operation Thermally Shutdown Junction Temperature Shutdown Reset from Shutdown		$V_{S} = \pm 40V$ $V_{S} = \pm 40V$	100	0.1 140 +160 +145	1.0 165	μА μΑ °С °С
POWER SUPPLY Supply Voltage Range Quiescent Current (per amplifier) over Temperature	V <sub>S</sub> I <sub>Q</sub>	I <sub>O</sub> = 0	±10	±5.5	±40 ±6.5 ± <b>7.5</b>	V mA <b>mA</b>
TEMPERATURE RANGE Specified Range (junction) Operating Range (junction) Storage Range (ambient) Thermal Resistance	T <sub>J</sub> T <sub>J</sub> T <sub>A</sub>		40 55 65		+125 +125 +150	S° S° S°
TO200-7 DDPAK-7	$ heta_{ m JC}$			3 3		°C/W °C/W

NOTE: (1) All tests are high-speed tested at +25°C ambient temperature. Effective junction temperature is +25°C, unless otherwise noted.





# ELECTRICAL CHARACTERISTICS: OPA453; V\_S = $\pm 10V$ to $\pm 40V$

**Boldface** limits apply over the specified junction temperature range,  $T_J = -40^{\circ}C$  to  $+125^{\circ}C$ .

At T<sub>J</sub> = +25°C, R<sub>L</sub> = 3.8k $\Omega$  connected to ground, and V<sub>OUT</sub> = 0V, unless otherwise noted.

				OPA453TA, FA	L	
PARAMETER		CONDITION	MIN	TYP	MAX	UNITS
OFFSET VOLTAGE Input Offset Voltage over Temperature Drift vs Power Supply over Temperature	V <sub>os</sub> dV <sub>os</sub> /dT PSRR	$V_{S} = \pm 40V, V_{CM} = 0V, I_{O} = 0V$ $V_{S} = \pm 10V$ to $\pm 40V, V_{CM} = 0V$		±1 ± <b>5</b> 5	±3 ±6 30 45	mV mV μV/°C μV/ν μV/ν
INPUT BIAS CURRENT <sup>(1)</sup>						
Input Bias Current Input Offset Current	I <sub>B</sub> I <sub>OS</sub>	$\begin{array}{l} V_{S}=\pm 40V, \ V_{CM}=0V\\ V_{S}=\pm 40V, \ V_{CM}=0V \end{array}$		±7 ±1	±100 ±100	рА рА
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INPUT IMPEDANCE Differential Common-Mode		V <sub>S</sub> = ±40V, -35V < V <sub>CM</sub> < 39.5V		10 <sup>13</sup>    2 10 <sup>13</sup>    6		Ω    pF Ω    pF
OPEN-LOOP GAIN Open-Loop Voltage Gain over Temperature	A <sub>OL</sub>	$\begin{split} I_{O} &= 10 \text{mA}, \ -V_{S} + 2\text{V} < V_{O} < +V_{S} - 2\text{V} \\ \textbf{I}_{O} &= 10 \text{mA}, \ -V_{S} + 2\text{V} < \textbf{V}_{O} < +V_{S} - 2\text{V} \\ I_{O} &= 50 \text{mA}, \ -V_{S} + 4\text{V} < V_{O} < +V_{S} - 4\text{V} \end{split}$	105 96	110 <b>107</b> 110		dB <b>dB</b> dB
over Temperature		$I_0 = 50mA, -V_S + 5V < V_0 < +V_S - 5.5V$		105		dB
FREQUENCY RESPONSE Gain-Bandwidth Product Slew Rate Settling Time: 0.1% 0.01% Overload Recovery Time Total Harmonic Distortion + Noise	GBW SR THD+N	$\begin{array}{c} V_{S}=\pm 40V\\ V_{S}=\pm 40V\\ \end{array}\\ V_{S}=\pm 40V, \ G=+5, \ 10V \ Step, \ C_{L}=100pF\\ V_{S}=\pm 40V, \ G=+5, \ 10V \ Step, \ C_{L}=100pF\\ \end{array}\\ \begin{array}{c} V_{IN} \bullet \ Gain=V_{S}\\ V_{S}=\pm 40V, \ V_{O}=30Vp\text{-}p, \ G=5\\ f=1kHz, \ R_{L}=2k\Omega \end{array}$		7.5 +23/-38 1 1.5 1 0.0008		MHz V/μs μs μs %
OUTPUT Voltage Output over Temperature Voltage Output over Temperature Output Current Short-Circuit Current Capacitive Load Drive	V <sub>OUT</sub> I <sub>SC</sub> C <sub>LOAD</sub>	I <sub>O</sub> = 50mA I <sub>O</sub> = <b>50mA</b> I <sub>O</sub> = 10mA I <sub>O</sub> = <b>10mA</b>	(V−) + 4.0 (V−) + 5 (V−) + 2 (V−) + 2 ±50 See	±125 Typical Characte	$(\vee +) - 4$ $(\vee +) - 5.5$ $(\vee +) - 2$ $(\vee +) - 2$ $(\vee +) - 2$ eristic	V V V mA mA
SHUTDOWN FLAG Thermal Shutdown Status Output Normal Operation Thermally Shutdown Junction Temperature Shutdown Reset from Shutdown	Lond	$V_{S} = \pm 40V$ $V_{S} = \pm 40V$	100	0.1 140 +160 +145	1.0 165	μА μΑ °С °С
POWER SUPPLY Supply Voltage Range Quiescent Current (per amplifier) over Temperature	V <sub>S</sub> I <sub>Q</sub>	I <sub>O</sub> = 0	±10	±5.5	±40 ±6.5 ± <b>7.5</b>	V mA <b>mA</b>
TEMPERATURE RANGE Specified Range (junction) Operating Range (junction) Storage Range (ambient) Thermal Resistance	$\begin{array}{c} T_{J}\\ T_{J}\\ T_{A} \end{array}$		40 55 65		+125 +125 +150	°C °C °C
TO200-7 DDPAK-7	ъĴС			3 3		°C/W °C/W

NOTE: (1) All tests are high-speed tested at +25°C ambient temperature. Effective junction temperature is +25°C, unless otherwise noted.

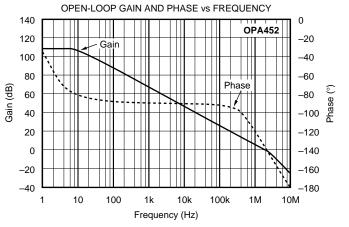


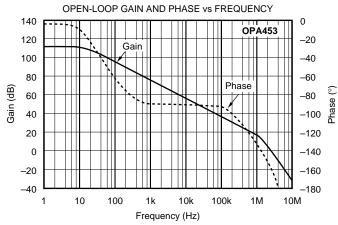
## **TYPICAL CHARACTERISTICS**

At T\_J = +25°C, V\_S =  $\pm 40V,$  and R\_L = 3.8k\Omega, unless otherwise noted.

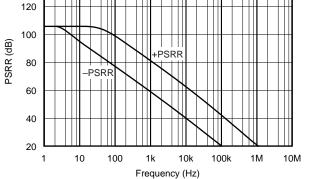
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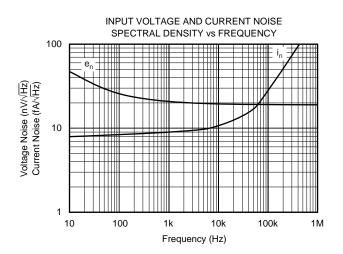




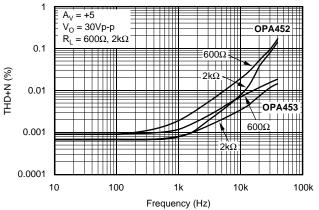
COMMON-MODE REJECTION RATIO vs FREQUENCY 120 100 80 CMRR (dB) 60 40 20 0 10 100 1k 10k 100k 1M 10M 1 Frequency (Hz)



POWER-SUPPLY REJECTION RATIO vs FREQUENCY



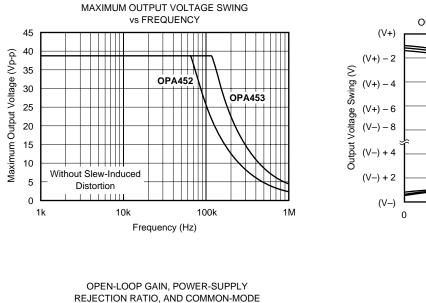
TOTAL HARMONIC DISTORTION + NOISE vs FREQUENCY



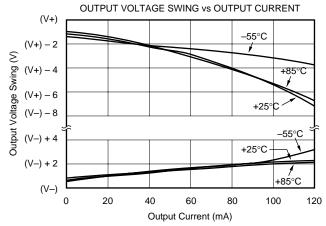
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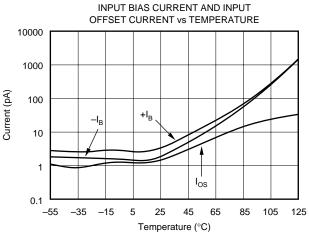
At  $T_J$  = +25°C,  $V_S$  =  $\pm 40V,$  and  $R_L$  = 3.8k\Omega, unless otherwise noted.

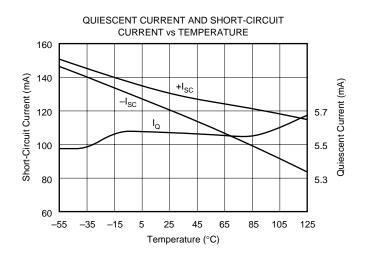
All temperatures are junction temperatures unless otherwise noted. Refer to the Applications Information section to calculate junction temperatures from ambient temperatures for a specific configuration.

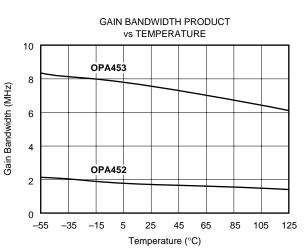


**REJECTION RATIO vs TEMPERATURE** 120 AOL AOL, PSRR, and CMRR (dB) 110 PSRR 100 CMRR 90 80 70 -35 5 25 45 65 85 105 125 -55 -15 Temperature (°C)







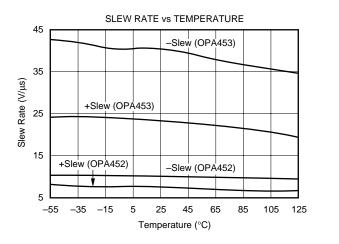


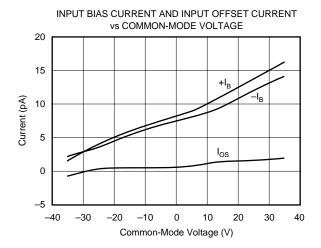


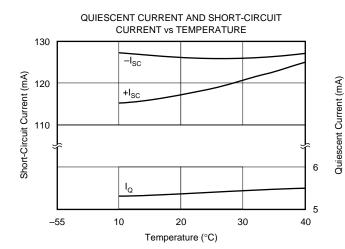
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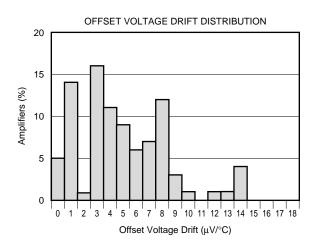
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All temperatures are junction temperatures unless otherwise noted. Refer to the Applications Information section to calculate junction temperatures from ambient temperatures for a specific configuration.

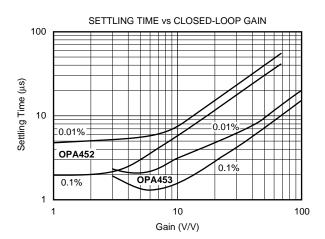








OFFSET VOLTAGE PRODUCTION DISTRIBUTION



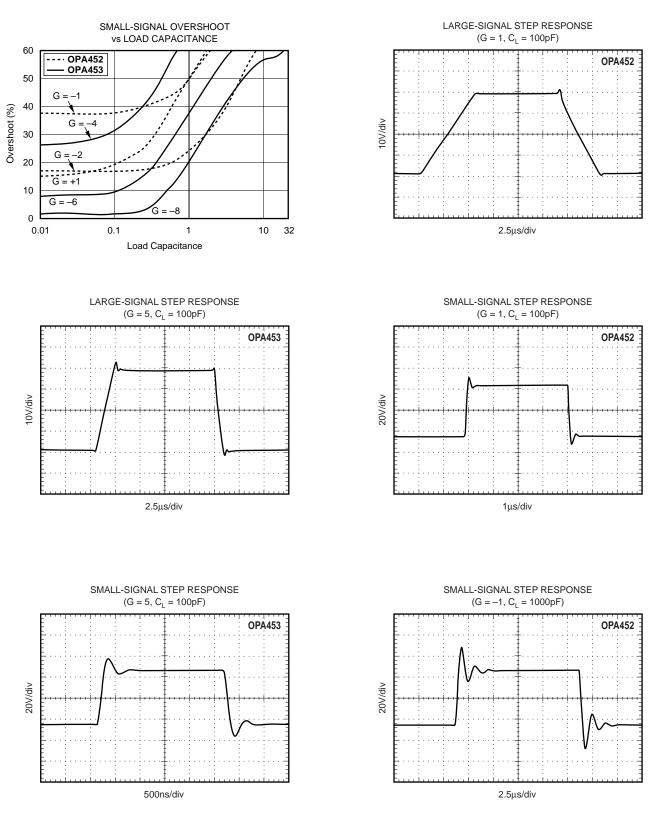




# **TYPICAL CHARACTERISTICS (Cont.)**

At  $T_J$  = +25°C,  $V_S$  =  $\pm 40V,$  and  $R_L$  = 3.8k\Omega, unless otherwise noted.

All temperatures are junction temperatures unless otherwise noted. Refer to the Applications Information section to calculate junction temperatures from ambient temperatures for a specific configuration.





# **APPLICATIONS INFORMATION**

Figure 1 shows the OPA452 connected as a basic noninverting amplifier. The OPA452 can be used in virtually any op amp configuration. The OPA453 is designed for use in configurations with gains of 5 or greater. Power-supply terminals should be bypassed with  $0.1\mu$ F capacitors, or greater, near the power-supply pins. Be sure that the capacitors are appropriately rated for the power-supply voltage used. The OPA452 and OPA453 can supply output currents up to 50mA with excellent performance.

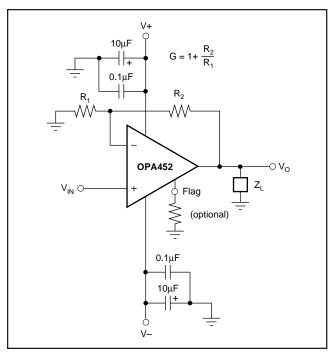


FIGURE 1. Basic Circuit Connections.

### **CURRENT LIMIT**

The OPA452 and OPA453 are designed with internal current-limiting circuitry that limits the output current to approximately 125mA. The current limit varies slightly with increasing junction temperature and supply voltage, as shown in the Typical Characteristics. Current limit, in combination with the thermal protection circuitry, provides protection from most types of overload conditions including short-circuit to ground.

### THERMAL PROTECTION

The OPA452 and OPA453 have thermal shutdown circuitry that protects the amplifier from damage caused by overload conditions. The thermal protection circuitry disables the output when the junction temperature reaches approximately 160°C, allowing the device to cool. When the junction temperature cools to approximately 140°C, the output circuitry is automatically re-enabled.

The thermal shutdown function is not intended to replace proper heat sinking. Activation of the thermal shutdown circuitry is an indication of excessive power dissipation or an inadequate heat sink. Continuously running the amplifier into thermal shutdown can degrade reliability.

The Thermal Shutdown Indicator (Flag) pin can be monitored to determine if shutdown is occurring. During normal operation, the current output from the flag pin is typically 50nA. During shutdown, the current output from the flag pin increases to 140 $\mu$ A (typical). This current output allows for easy interfacing to external logic. Figure 2 shows two examples implementing this function.

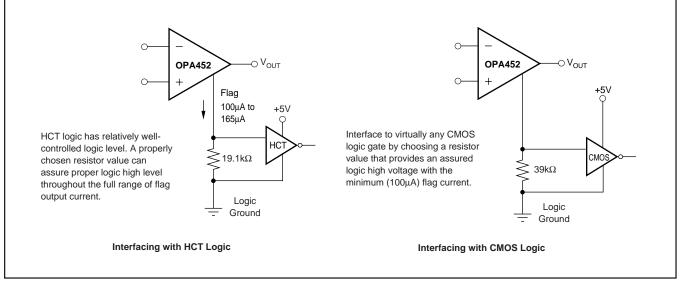


FIGURE 2. Thermal Shutdown Indicator.



#### **POWER SUPPLIES**

The OPA452 and OPA453 may be operated from power supplies of  $\pm 10V$  to  $\pm 40V$ , or a total of 80V with excellent performance. Most behavior remains unchanged throughout the full operating voltage range. Parameters that vary significantly with operating voltage are shown in the Typical Characteristics.

For applications that do not require symmetrical output voltage swing, power-supply voltages do not need to be equal. The OPA452 and OPA453 can operate with as little as 20V between the supplies or with up to 80V between the supplies. For example, the positive supply could be set to 70V with the negative supply at -10V or vice-versa.

The tabs of the DDPAK-7 and TO220 packages are electrically connected to the negative supply (V–), however, these connections should not be used to carry current. For best thermal performance, the tab should be soldered directly to the circuit board copper area (see Heat Sinking section).

#### POWER DISSIPATION

Internal power dissipation of these op amps can be quite large. All of the specifications for the OPA452 and OPA453 may change with junction temperature. If the device is not subjected to internal self-heating, the junction temperature will be the same as the ambient. However, in practical applications, the device will self-heat and the junction temperature will be significantly higher than ambient. The following calculation can be performed to establish junction temperature as a function of ambient temperature and the conditions of the application.

Consider the OPA452 in a circuit configuration where the load is 600 $\Omega$  and the output voltage is 20V. The supplies are at ±40V and the ambient temperature (T<sub>A</sub>) is 40°C. The  $\theta_{JA}$  for the package plus heat sink is 30°C/W.

First, the quiescent heating of the op amp is as follows:

 $P_{D(internal)} = I_Q \bullet V_S = 6mA \bullet 80V = 480mW$ 

The output current  $(I_{O})$  can be calculated:

 $I_0 = V_0/R_L = 20V/600\Omega = 33.33mA$ 

The power being dissipated  $(P_D)$  in the output transistor of the amplifier can be calculated:

$$\begin{split} P_{D(output \; stage)} &= I_{O} \bullet (V_{S} - V_{O}) = 33.3 \text{mA} \bullet (40 - 20) = 667 \text{mW} \\ P_{D(total)} &= P_{D(internal)} + P_{D(output \; stage)} = 480 \text{mW} + 667 \text{mW} = 1147 \text{mW} \\ \text{The resulting junction temperature can be calculated:} \end{split}$$

$$T_J = T_A + P_D \theta_{JA}$$
  
 $T_J = 40^{\circ}\text{C} + 1147\text{mW} \cdot 30^{\circ}\text{C/W} = 74.4^{\circ}\text{C}$ 

Where,

- $V_{O}$  = output voltage  $V_{S}$  = supply voltage
- $I_{\Omega}$  = output current
- $R_1 = load resistance$
- $T_{J}$  = junction temperature (°C)
- $T_A$  = ambient temperature (°C)
- $\theta_{JA}$  = junction-to-air thermal resistance (°C/W)

To estimate the margin of safety in a complete design (including heat sink), increase the ambient temperature until the thermal protection is activated. Use worst-case load and signal conditions. For good reliability, the thermal protection should trigger more than  $+35^{\circ}$ C above the maximum expected ambient condition of your application. This ensures a maximum junction temperature of  $+125^{\circ}$ C at the maximum expected ambient condition.

Operation from a single power supply (or unbalanced power supplies) can produce even larger power dissipation because a larger voltage can be impressed across the conducting output transistor. Consult Application Bulletin SBOA022 at www.ti.com for further information on how to calculate or measure power dissipation.

Power dissipation can be minimized by using the lowest possible supply voltage. For example, with a 50mA load, the output will swing to within 5.0V of the power-supply rails. Power supplies set to no more than 5.0V above the maximum output voltage swing required by the application will minimize the power dissipation.

#### SAFE OPERATING AREA

The Safe Operating Area (SOA curves, Figure 3) shows the permissible range of voltage and current. The safe output current decreases as the voltage across the output transistor  $(V_S - V_O)$  increases. For further insight on SOA, consult Application Report SBOA022.

Output short circuits are a very demanding case for SOA. A short-circuit to ground forces the full power-supply voltage (V+ or V–) across the conducting transistor and produces a

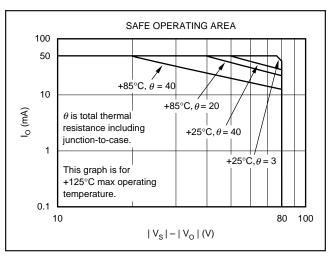


FIGURE 3. DDPAK-7 and TO220-7 Safe Operating Area.



typical output current of 125mA. With  $\pm$ 40V power supplies, this creates an internal dissipation of 10W. This far exceeds practical heat sinking and is not recommended. If operation in this region is unavoidable, use the part with a heat sink.

#### **HEAT SINKING**

Power dissipated in the OPA452 or OPA453 will cause the junction temperature to rise. For reliable operation, the junction temperature should be limited to +125°C. Many applications will require a heat sink to assure that the maximum operating junction temperature is not exceeded. The heat sink required depends on the power dissipated and on ambient conditions.

For heat sinking purposes, the tab of the DDPAK is typically soldered directly to a circuit board copper area. Increasing the copper area improves heat dissipation. Figure 4 shows typical thermal resistance from junction-to-ambient as a function of copper area.

Depending on conditions, additional heat sinking may be required. Aavid Thermal Products Inc. manufactures surface-mountable heat sinks designed specifically for use with these packages. Further information is available on Aavid's web site, www.aavid.com.

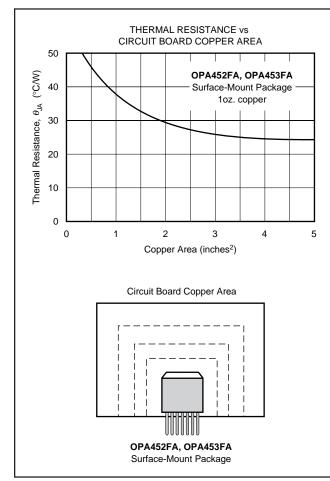


FIGURE 4. DDPAK Thermal Resistance versus Circuit Board Copper Area.

#### CAPACITIVE LOADS

The dynamic characteristics of the OPA452 and OPA453 have been optimized for commonly encountered gains, loads, and operating conditions. The combination of low closed-loop gain and capacitive load will decrease the phase margin and may lead to gain peaking or oscillations. Figure 5 shows a circuit that preserves phase margin with capacitive load. Figure 6 shows the small-signal step response for the circuit in Figure 5. Consult Application Bulletin SBOA015, at www.ti.com, for more information.

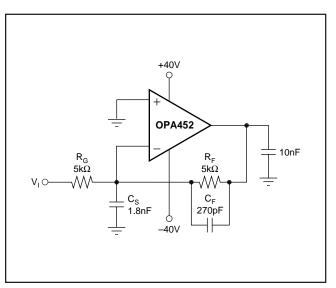


FIGURE 5. Driving Large Capacitive Loads.

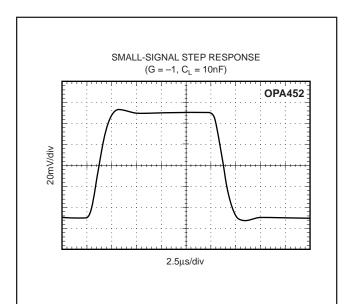


FIGURE 6. Small-Signal Step Response for Figure 5.



#### **INCREASING OUTPUT CURRENT**

In those applications where the 50mA of output current is not sufficient to drive the desired load, output current can be increased by connecting two or more OPA452s or OPA453s in parallel, as shown in Figure 7. Amplifier A1 is the master amplifier and may be configured in virtually any op amp circuit. Amplifier A2, the slave, is configured as a unity gain buffer. Alternatively, external output transistors can be used to boost output current. The circuit in Figure 8 is capable of supplying output currents up to 1A. Alternatively, the OPA547, OPA548, and OPA549 series power op amps should be considered for high output current drive, along with programmable current limit and output disable capability.

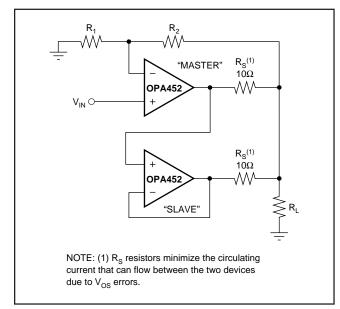


FIGURE 7. Parallel Amplifiers Increase Output Current Capability.

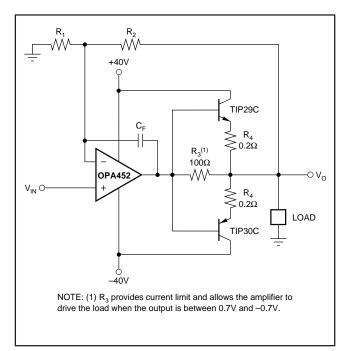


FIGURE 8. External Output Transistors Boost Output Current Up to 1 Amp.

### INPUT PROTECTION

The OPA452 and OPA453 feature internal clamp diodes to protect the inputs when voltages beyond the supply rails are encountered. However, input current should be limited to 5mA. In some cases, an external series resistor may be required. Many input signals are inherently current-limited, therefore, a limiting resistor may not be required. Please consider that a large series resistor, in conjunction with the input capacitance, can affect stability.

#### **USING THE OPA453 IN LOW GAINS**

The OPA453 is intended for applications with signal gains of 5 or greater, but it is possible to take advantage of its high slew rate in lower gains using an external compensation technique in an inverting configuration. This technique maintains low noise characteristics of the OPA453 architecture at low frequencies. Depending on the application, a small increase in high-frequency noise may result. This technique shapes the loop gain for good stability while giving an easily controlled 2nd-order low-pass frequency response.

Considering only the noise gain (noninverting signal gain) for the circuit of Figure 9, the low-frequency noise gain (NG<sub>1</sub>) will be set by the resistor ratios, whereas the high-frequency noise gain (NG<sub>2</sub>) will be set by the capacitor ratios. The capacitor values set both the transition frequencies and the high-frequency noise gain. If this noise gain, determined by NG<sub>2</sub> =  $1 + C_S/C_F$ , is set to a value greater than the recommended minimum stable gain for the op amp and the noise gain pole, set by  $1/R_FC_F$ , is placed correctly, a very well controlled, 2nd-order low-pass frequency response will result.

To choose the values for both  $C_S$  and  $C_F$ , two parameters and only three equations need to be solved. First, the target for the high-frequency noise gain (NG<sub>2</sub>) should be greater than the minimum stable gain for the OPA453. In the circuit in Figure 9, a target NG<sub>2</sub> of 10 is used. Second, the signal gain of -1 in Figure 10 sets the low-frequency noise gain to NG<sub>1</sub> = 1 + R<sub>F</sub>/R<sub>G</sub> (= 2 in this example). Using these two gains, knowing the Gain Bandwidth Product (GBP) for the OPA453 (7.5MHz), and targeting a maximally flat 2nd-order, low-pass Butterworth frequency response (Q = 0.707), the key frequency in the compensation can be found.

For the values in Figure 9, the  $f_{-3dB}$  will be approximately 180kHz. This is less than that predicted by simply dividing the GBP by NG<sub>1</sub>. The compensation network controls the bandwidth to a lower value while providing good slew rate at the output and an exceptional distortion performance due to increased loop gain at frequencies below NG<sub>1</sub> • Z<sub>0</sub>. The capacitor values in Figure 10 are calculated for NG<sub>1</sub> = 2 and NG<sub>2</sub> = 10 with no adjustment for parasitics.

Actual circuit values can be optimized by checking the small-signal step response with actual load conditions. See Figure 9 for the small-signal step response of this OPA453, G = -1 circuit with a 1000pF load. It is well-behaved with no tendency to oscillate. If C<sub>S</sub> and C<sub>F</sub> were removed, the circuit would be unstable.





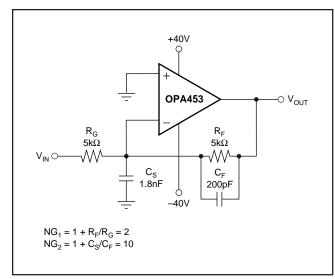


FIGURE 9. Compensation of the OPA453 for G = -1.

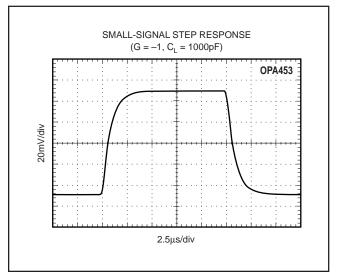


FIGURE 10. Small-Signal Step Response for Figure 9.



1-Aug-2008

### **PACKAGING INFORMATION**

MENTS

www ti com

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Packag Qty	e Eco Plan <sup>(2)</sup> L	ead/Ball Fini	sh MSL Peak Temp <sup>(3)</sup>
OPA452FA	OBSOLETE	DDPAK	KTW	7		TBD	Call TI	Call TI
OPA452FA/500	ACTIVE	DDPAK	KTW	7	500	Green (RoHS & no Sb/Br)	CU SN	Level-3-245C-168 HR
OPA452FA/500G3	ACTIVE	DDPAK	KTW	7	500	Green (RoHS & no Sb/Br)	CU SN	Level-3-245C-168 HR
OPA452FAKTWT	ACTIVE	DDPAK	KTW	7	50	Green (RoHS & no Sb/Br)	CU SN	Level-3-245C-168 HR
OPA452FAKTWTG3	ACTIVE	DDPAK	KTW	7	50	Green (RoHS & no Sb/Br)	CU SN	Level-3-245C-168 HR
OPA452TA	ACTIVE	TO-220	KC	7	50	Green (RoHS & no Sb/Br)	CU SN	N / A for Pkg Type
OPA452TA-1	ACTIVE	TO-220	KVT	7	50	Green (RoHS & no Sb/Br)	CU SN	N / A for Pkg Type
OPA452TA-1G3	ACTIVE	TO-220	KVT	7	50	Green (RoHS & no Sb/Br)	CU SN	N / A for Pkg Type
OPA452TAG3	ACTIVE	TO-220	KC	7	50	Green (RoHS & no Sb/Br)	CU SN	N / A for Pkg Type
OPA453FA	OBSOLETE	DDPAK	KTW	7		TBD	Call TI	Call TI
OPA453FAKTWT	ACTIVE	DDPAK	KTW	7	50	Green (RoHS & no Sb/Br)	CU SN	Level-3-245C-168 HR
OPA453TA	ACTIVE	TO-220	KC	7	50	Green (RoHS & no Sb/Br)	CU SN	N / A for Pkg Type
OPA453TA-1	ACTIVE	TO-220	KVT	7	50	Green (RoHS & no Sb/Br)	CU SN	N / A for Pkg Type
OPA453TA-1G3	ACTIVE	TO-220	KVT	7	50	Green (RoHS & no Sb/Br)	CU SN	N / A for Pkg Type
OPA453TAG3	ACTIVE	TO-220	KC	7	50	Green (RoHS & no Sb/Br)	CU SN	N / A for Pkg Type

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

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<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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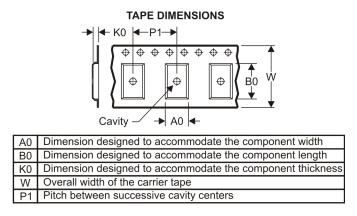
### PACKAGE OPTION ADDENDUM

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### TAPE AND REEL INFORMATION





### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*A	All dimensions are nominal												
	Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
	OPA452FA/500	DDPAK	KTW	7	500	330.0	24.4	10.6	15.6	4.9	16.0	24.0	Q2
	OPA452FAKTWT	DDPAK	KTW	7	50	330.0	24.4	10.6	15.6	4.9	16.0	24.0	Q2
	OPA453FAKTWT	DDPAK	KTW	7	50	330.0	24.4	10.6	15.6	4.9	16.0	24.0	Q2



## PACKAGE MATERIALS INFORMATION

30-May-2008

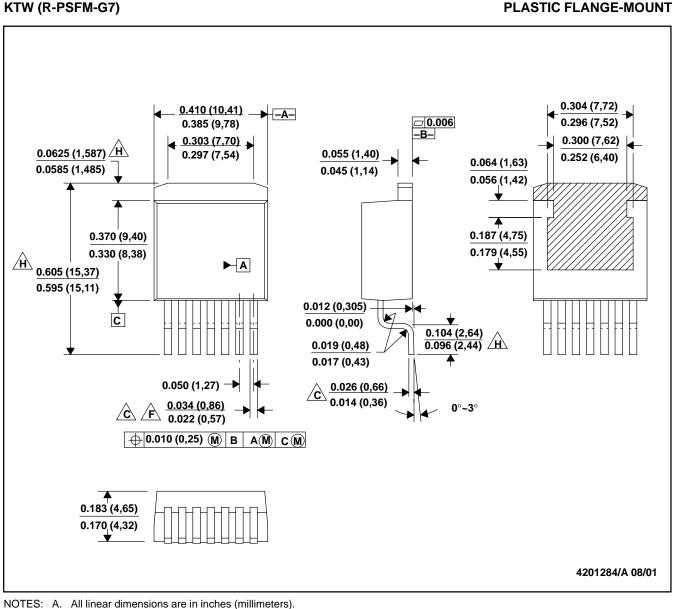


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
OPA452FA/500	DDPAK	KTW	7	500	346.0	346.0	41.0
OPA452FAKTWT	DDPAK	KTW	7	50	346.0	346.0	41.0
OPA453FAKTWT	DDPAK	KTW	7	50	346.0	346.0	41.0

### **MECHANICAL DATA**

MPSF015 - AUGUST 2001



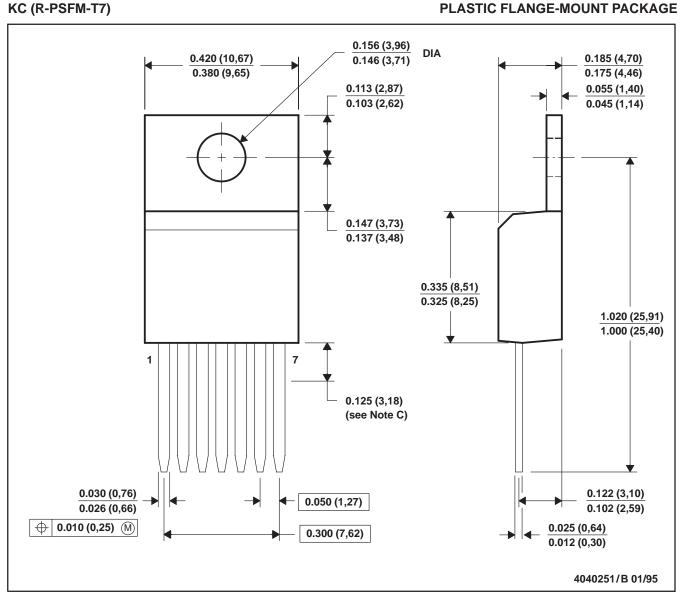
S: A. All linear dimensions are in inches (millimeters).
 B. This drawing is subject to change without notice.

- C. Lead width and height dimensions apply to the plated lead.
- D. Leads are not allowed above the Datum B.
- E. Stand–off height is measured from lead tip with reference to Datum B.
- F. Lead width dimension does not include dambar protrusion. Allowable dambar protrusion shall not cause the lead width to exceed the maximum dimension by more than 0.003".
- G. Cross-hatch indicates exposed metal surface.
- A Falls within JEDEC MO–169 with the exception of the dimensions indicated.



### **MECHANICAL DATA**

MSOT010 - OCTOBER 1994

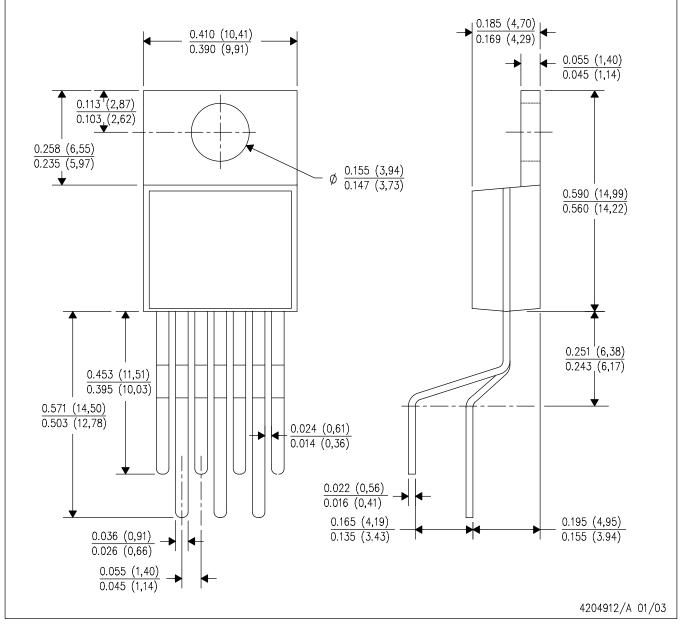


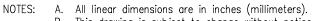
NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. Lead dimensions are not controlled within this area.
- D. All lead dimensions apply before solder dip.
- E. The center lead is in electrical contact with the mounting tab.



KVT (R-PZFM-T7)





B. This drawing is subject to change without notice.

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